



深圳市宝安区西乡三围奋达科技创意园E栋

Building E, Fenda Science Park, Sanwei Community, Xixiang Street, Bao'an District, Shenzhen Guandong China Tel:(0755) 61156588 Fax:(0755) 61156599 Web:www.ntek.org.cn Mail:ntek@ntek.org.cn

Test Lab Attestation Letter

This attestation is to confirm that the below listed device was tested and report at our Test Facilities located at:

Test Lab Name: NTEK Testing Technology Co., Ltd.

Test Lab Address: 1/F, Building E, Fenda Science Park, Sanwei Community, Xixiang Street,

Bao' an District, Shenzhen P.R. China

Test Lab Registration Number: 238937

June. 03, 2013 to June. 09, 2013 Date of Test:

Test Report Number: POCE13062017FRF

Applicant Name: SHENZHEN MAXIMUM ELECTRONICS CO., LTD.

FCC ID: 2AAFJSC200AEL

Name of Engineer(s)

Performing Test: **Bill Jiang**

TEST LABORATORY:

Signature of Authorized Representative of the Test Laboratory:

Full Contact Name:

E-mail

Bovey.yang@ntek.org.cn

Position/Title:

Manger

Bovey